

Features

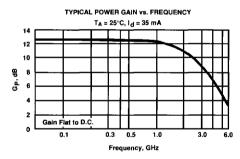
- Cascadable 50 Ω Gain Block
- 3 dB Bandwidth: DC to 2.8 GHz
- 12.0 dB typical Gain at 1.0 GHz
- 10.0 dBm typical P_{1 dB} at 1.0 GHz

Description

The MSA-0300 is a high performance silicon bipolar Monolithic Microwave Integrated Circuit (MMIC) chip. This MODAMP¹M MMIC is designed for use as a general purpose 50 Ω gain block. Typical applications include narrow and broad band IF and RF amplifiers in commercial, industrial and military applications.

The MODAMP MSA-series is fabricated using a 10 GHz f_{T} , 25 GHz f_{MAX} silicon bipolar MMIC process which utilizes nitride self-alignment, ion implantation and gold metallization to achieve excellent uniformity, performance, and reliability. The use of an external bias resistor for temperature and current stability also allows bias flexibility.

The recommended assembly procedure is gold-eutectic die attach at 400°C and either wedge or ball bonding using 0.7 mil gold wire. See APPLICATIONS section, "Chip Use".



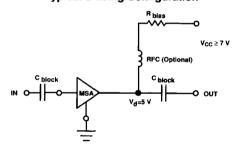
Chip Outline¹ NOT APPLICABLE INPUT GROUND OPTIONAL OUTPUT *

Unless otherwise specified, tolerances are ±13 µm / ±0.5 mils.
Chip thickness is 114 µm / 4.5 mil. Bond pads

are 41 μ m / 1.6 mil typical on each side.

 Output contact is made by die attaching the backside of the die.

Typical Biasing Configuration



Electrical Specifications², T_A = 25°C

Symbol	Parameters and Test Conditions ³ : I _d = 35 m ²	Units	Min.	Тур.	Max.	
GP	Power Gain (S21 2)	f = 0.1 GHz	dB		12.5	
ΔGP	Gain Flatness	f = 0.1 to 1.8 GHz	dB		±0.6	
f3 dB	3 dB Bandwidth		GHz		2.8	
	Input VSWR	f = 0.1 to 3.0 GHz			1.8:1	
VSWR	Output VSWR	f = 0.1 to 3.0 GHz			1.8:1	
P _{1 dB}	Output Power @ 1 dB Gain Compression	f = 1.0 GHz	dBm		10.0	
NF	50 Ω Noise Figure	f = 1.0 GHz	dB		6.0	
IP ₃	Third Order Intercept Point	f = 1.0 GHz	dBm		23.0	
to	Group Delay	f = 1.0 GHz	psec.		125	
Vd	Device Voltage		٧	4.5	5.0	5.5
dV/dT	Device Voltage Temperature Coefficient		mV/°C		-8.0	

Notes: 1. This chip contains additional biasing options. The performance specified applies only to the bias option whose bond pads are indicated on the chip outline. Refer to the APPLICATIONS section "MODAMP1" Silicon MMIC Chip Use" for additional information.

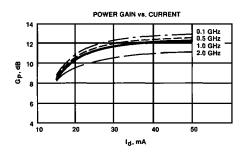
- 2. The recommended operating current range for this device is 20 mA to 50 mA. Typical performance as a function of current is on the following page.
- 3. RF performance of the chip is determined by packaging and testing 10 devices per wafer in a dual ground configuration.

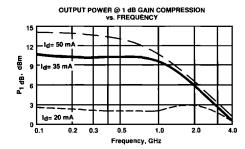
Absolute Maximum Ratings

Parameter	Absolute Maximum ¹
Device Current	80 mA
Power Dissipation ^{2,3}	425 mW
RF Input Power	+13 dBm
Junction Temperature	200°C
Storage Temperature	-65°C to 200°C

Notes:

- 1. Permanent damage may occur if any of these limits are exceeded.
- 2. TCASE = 25°C
- 3. Derate at 22.2 mW/°C for T_C > 181°C.
- 4. The small spot size of this technique results in a higher, though more accurate determination of $\theta_{\rm jc}$ than do alternate methods. See MEASUREMENTS section "Thermal Resistance" for more information.





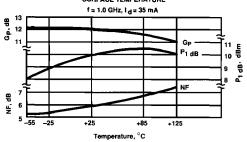
Part Number Ordering Information

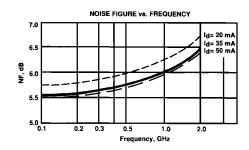
Part Number	Devices Per Tray				
MSA-0300-GP2	10				
MSA-0300-GP4	100				
MSA-0300-GP6	up to 300				

Typical Performance, T_A = 25°C

(unless otherwise noted)

OUTPUT POWER @ 1 dB GAIN COMPRESSION NOISE FIGURE AND POWER GAIN vs. MOUNTING SURFACE TEMPERATURE





Typical Scattering Parameters*: $Z_0 = 50 \Omega$					T,			$T_A = 3$	$A = 25$ °C, $I_d = 35$ mA		
_	S ₁₁		S ₂₁			S ₁₂			S ₂₂		
Freq. GHz	Mag	Ang	dB	Mag	Ang	dB	Mag	Ang	Mag	Ang	k
0.1	.13	~179	12.6	4.28	177	-18.6	.118	2	.09	-13	1.21
0.2	.13	~179	12.6	4.27	172	-18.3	.121	3	.10	-27	1.19
0.4	.12	-179	12.5	4.24	165	-18.3	.121	5	.12	-48	1.19
0.6	.11	-177	12.5	4.22	158	-18.2	.123	8	.14	-6 5	1.18
8.0	.11	-172	12.4	4.19	152	-17.8	.129	11	.17	-76	1.15
1.0	.10	-166	12.4	4.15	144	-17.7	.130	12	.20	-85	1.14
1.5	.11	-145	12.0	4.00	126	-17.1	.139	17	.24	-104	1.09
2.0	.16	-140	11.5	3.76	109	-16.2	.154	20	.27	-122	1.03
2.5	.23	~141	10.8	3.47	97	-15.6	.166	25	.28	-133	0.99
3.0	.29	-149	9.8	3.10	82	-15.2	.173	24	.28	-145	0.99
3.5	.35	- 157	8.7	2.72	67	-14.5	.188	22	.27	-148	0.97
4.0	.38	-164	7.6	2.40	55	-14.3	.193	21	.25	-146	1.00
5.0	.41	179	5.5	1.88	35	-13.7	.206	17	.21	-134	1.14
6.0	.43	153	3.6	1.51	18	-13.3	.217	14	.21	-137	1.27

Note: 4. S-parameters are de-embedded from 70 mil package measured data using the package model found in the DEVICE MODELS section.